


<b>Search Notes</b> 	<b>Application/Control No.</b> 10571285	<b>Applicant(s)/Patent Under Reexamination</b> HAYASHI ET AL.
	<b>Examiner</b> KRISTIN BIANCHI	<b>Art Unit</b> 1626

SEARCHED			
Class	Subclass	Date	Examiner
514	337	09/09/08	KB
514	415	09/09/08	KB
546	277.4	09/09/08	KB
548	495	09/09/08	KB
548	469	09/09/08	KB

SEARCH NOTES		
Search Notes	Date	Examiner
inventor name search (EAST)	09/08/08	KB
STIC STN search results (EAST and NPL)	09/08/08	KB
IDS/prior art (EAST and eDAN)	09/08/08	KB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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